MT30046S

N-Channel Power MOSFET

 $30V,90A,4.6m\Omega$

Features

- $R_{DS(on)}$ = 4.6 m Ω at V_{GS} = 10V, I_D = 30A
- · Fast Switching Speed
- · Low Gate Charge
- High Performance Trench Technology for Extr emely Low $R_{DS(on)}$
- · High Power and Current Handling Capability
- RoHS Compliant

General Description

This N-Channel MOSFET is produced using MOS-TECH Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

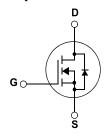
Applications

- · DC-DC primary bridge
- DC-DC Synchronous rectification
- Hot swap



http://www.mtsemi.com

Simplified Schematic



MARKING DIAGRAM & PIN ASSIGNMENT



MOSFET Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted

Absolute Maximum Ratings T _A =25°C unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V_{DS}	30	V			
		V_{GS}	±20	V			
Continuous Drain	T _C =25°C		90				
Current ^G	T _C =100°C	I _D	40	A			
Pulsed Drain Current ^C		I _{DM}	150	7			
Avalanche Current ^C		I _{AR}	30	A			
Repetitive avalanche energy L=0.3mH ^C		E _{AR}	135	mJ			
	T _C =25°C	Ь	50	10/			
Power Dissipation ^B	T _C =100°C	$-P_{D}$	25	W			
	T _A =25°C	Ь	3	10/			
Power Dissipation ^A	T _A =70°C	-P _{DSM}	2.1	W			
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 175	°C			

Thermal Characteristics						
Parameter	Symbol	Тур	Max	Units		
Maximum Junction-to-Ambient ^A	t ≤ 10s	- R _{⊕JA}	15	20	°C/W	
Maximum Junction-to-Ambient ^A	Steady-State	INeJA	41	50	°C/W	
Maximum Junction-to-Case ^B	Steady-State	$R_{\theta JC}$	2.1	3	°C/W	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
MT30046S	MT30046S	TO-252	-	=	2500

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Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC F	PARAMETERS					
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250uA, V _{GS} =0V	30			V
I	Zero Gate Voltage Drain Current	V _{DS} =20V, V _{GS} =0V			1	^
I _{DSS}	Zero date voltage Brain durient	T _J =55°C			5	μΑ
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V			100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250$ μA	1	1.4	2.5	V
I _{D(ON)}	On state drain current	V _{GS} =10V, V _{DS} =5V	150			Α
	0.00	V _{GS} =10V, I _D =30A		4.6	5.5	mΩ
$R_{DS(ON)}$	Static Drain-Source On-Resistance			6.2		
		V _{GS} =4.5V, I _D =20A		7.8	8.5	
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =20A		49		S
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.74	1	V
I _S	Maximum Body-Diode Continuous Current				50	A
	PARAMETERS		<u> </u>		·	
C _{iss}	Input Capacitance			2050	2460	pF
C _{oss}	Output Capacitance	V _{GS} =0V, V _{DS} =12.5V, f=1MHz		485		pF
C _{rss}	Reverse Transfer Capacitance	1		280		pF
R_q	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		0.86	1.5	Ω
<u> </u>	NG PARAMETERS	00 100	<u> </u>		<u> </u>	
Q _g (10V)	Total Gate Charge			34	41	nC
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =12.5V, I _D =20A		17	22	nC
Q_{gs}	Gate Source Charge	V _{GS} -10V, V _{DS} -12.5V, I _D -20A		5		nC
Q_{gd}	Gate Drain Charge	1		3.5		nC
t _{D(on)}	Turn-On DelayTime			7.5		ns
t _r	Turn-On Rise Time	V _{GS} =10V, V _{DS} =12.5V,		11		ns
$t_{D(off)}$	Turn-Off DelayTime	R_L =0.68 Ω , R_{GEN} =3 Ω		27		ns
t _f	Turn-Off Fall Time]		8		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=100A/μs		30	36	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =20A, dI/dt=100A/μs		19		nC

A: The value of R $_{8JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_A$ =25°C. The Power dissipation P $_{DSM}$ is based on R $_{8JA}$ and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

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B. The power dissipation P_D is based on T_{J(MAX)}=175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature T _{J(MAX)}=175°C.

D. The R $_{\text{BJA}}$ is the sum of the thermal impedence from junction to case R $_{\text{BJC}}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 $\,\mu s$ pulses, duty cycle 0.5% max.

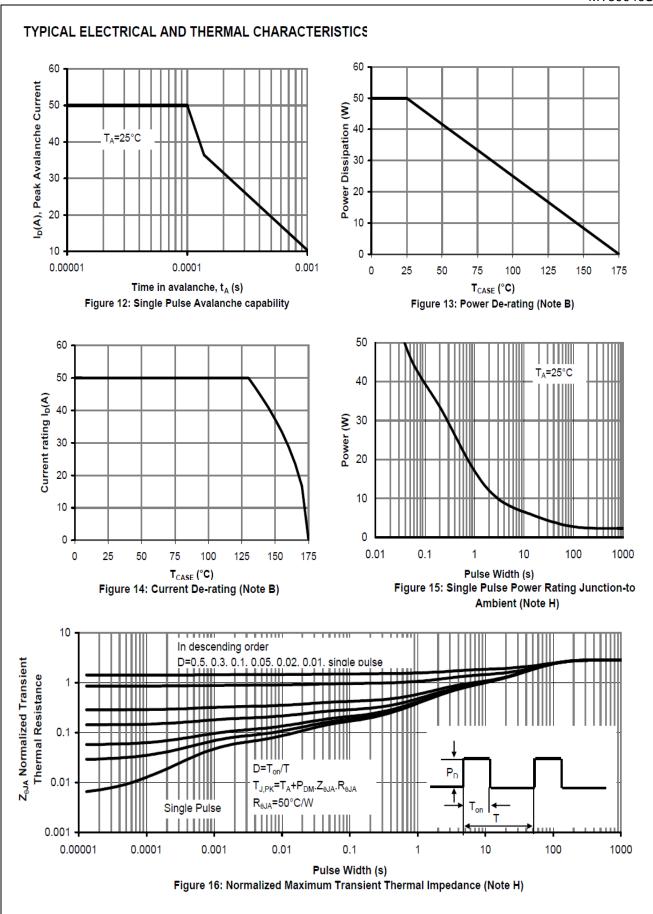
F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T J(MAX)=175°C.

 $[\]ensuremath{\mathsf{G}}.$ The maximum current rating is limited by bond-wires.

H. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_A$ =25°C. The SOA curve provides a single pulse rating. Rev1: March 2006

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS 10V 50 V_{DS}=5V 4.5V 100 40 I_D (A) **8** 30 3.5V 125°C 25°C 50 20 3.0∨ 10 V_{GS}=2.5 0 0 5 2 3 5 V_{DS} (Volts) V_{GS}(Volts) Fig 1: On-Region Characteristics Figure 2: Transfer Characteristics 10 1.8 Normalized On-Resistance 1.6 8 V_{GS}=10V, 20A V_{GS}=4.5∨ R_{DS(ON)} (mΩ) 1.4 1.2 V_{GS}=4.5V, 20A V_{GS}=10V 2 0.8 0 10 20 30 40 50 60 25 50 75 100 125 150 175 I_D (A) Temperature (°C) Figure 3: On-Resistance vs. Drain Current and Gate Figure 4: On-Resistance vs. Junction Temperature Voltage 12 100 I_D=20A 10 125°C 10 1 R_{DS(ON)} (mΩ) I_s (A) 0.1 8 0.01 25°C 125°C 0.001 6 0.0001 25°C 0.00001 4 0.0 0.2 0.4 0.6 0.8 1.2 1.0 3 5 7 4 6 8 9 10 V_{SD} (Volts) V_{GS} (Volts) Figure 6: Body-Diode Characteristics Figure 5: On-Resistance vs. Gate-Source Voltage

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS 3000 10 2500 8 V_{DS}=12.5V Ciss Capacitance (pF) 0001 0001 0001 I_D=20A V_{GS} (Volts) 6 Coss 2 500 0 0 10 0 5 15 20 25 30 35 40 0 5 10 15 25 20 Q_a (nC) V_{DS} (Volts) Figure 8: Capacitance Characteristics Figure 7: Gate-Charge Characteristics 1000 200 T_{J(Max)}=175°C, T_C=25°C 160 T_{J(Max)}=175°C 10μs 100 T_C=25°C **Dower (W)** 80 100μs l_D (Amps) 10 R_{DS(ON)} 1ms limited 1 40 0 0.1 0.001 0.01 0.1 0.0001 1 10 0.1 10 100 V_{DS} (Volts) Pulse Width (s) Figure 10: Single Pulse Power Rating Junction-to-Figure 9: Maximum Forward Biased Case (Note F) Safe Operating Area (Note F) 10 D=T_{on}/T In descending order **Z**_{0JC} Normalized Transient $\mathsf{T}_{\mathsf{J},\mathsf{PK}}\text{=}\mathsf{T}_{\mathsf{C}}\text{+}\mathsf{P}_{\mathsf{DM}}.\mathsf{Z}_{\mathsf{\theta}\mathsf{JC}}.\mathsf{R}_{\mathsf{\theta}\mathsf{JC}}$ D=0.5, 0.3, 0.1, 0.05, 0.02, 0.01, single pulse Thermal Resistance R_{eJC}=3°C/W Single Pulse 0.01 0.00001 0.0001 0.001 0.01 0.1 10 100 Pulse Width (s) Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



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